

Receipt date: 02/13/2006 INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	Docket Number (Optional) SAIT-4480	Application Number 10568336
Applicant(s) Mikio Fukuda		Filing Date 10568336
Group Art Unit GAU: 2618		13 FEB 2006

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS

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FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		2004-187031	7/2004	JP			✓	
		1-63289	4/1989	JP			✓	
		56-43986	4/1981	JP			✓	
		58-155186	10/1983	JP			✓	
		2003-198680	7/2003	JP			✓	

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

EXAMINER	DATE CONSIDERED
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ATTY DOCKET NO.

SAIT-4480

APPLICATION NO.

107308336

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APPLICANT(S)

Mikio Fukuda

FILING DATE

GROUP ART UNIT

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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	2003-174495	6/2003	JP			✓	
	2003-179678	6/2003	JP			✓	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

/ASG/ 11/05/2008

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